

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/656,409	D'AGUANNO, FRANCIS D.	
				Examiner	Art Unit	
				Randall Chin	1744	

<b>SEARCHED</b>			
Class	Subclass	Date	Examiner
15	185		
15	236.01		
15	236.05		
15	236.06		
15	236.07		
15	236.08		
15	236.09		
30	153		
30	255		
7	128		
81	177.6		
81	177.7	✓	✓
81	427.5	9/18/2006	RC
UPDATED	SREH	4/18/07	RE

<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		
Inventor name search		
Hwei-Siu Payer, Cl..30 search	✓	✓
Debra Meislin, Cl. 7 and 81 search	9/18/2006	RC

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner